Notice of References Cited Application/Control No. 10/085,145 Applicant(s)/Patent Under Reexamination MEISER ET AL. Examiner Tan Dean D. Nguyen Applicant(s)/Patent Under Reexamination MEISER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,006,197	12-1999	d'Eon et al.	705/10
*	В	US-2002/0123957	09-2002	Notarius et al.	705/37
	С	US-			
	D	US-			
	Е	US-			
	F	US-			-
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	υ	Oracle iMarketing, Dec. 1999
	>	
	w	
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